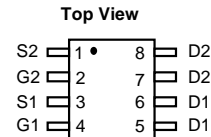


## 30V Dual N-channel MOSFET

### Description

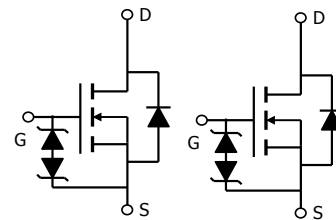
The SM4818 uses advanced trench technology to provide excellent  $R_{DS(ON)}$  and low gate charge. This device is suitable for use as a load switch or in PWM applications.



SOIC-8

### General Features

$V_{DS}$	30V
$I_D$ (at $V_{GS}=10V$ )	8A
$R_{DS(ON)}$ (at $V_{GS}=10V$ )	<19m $\Omega$
$R_{DS(ON)}$ (at $V_{GS} = 4.5V$ )	< 23m $\Omega$



### ◆ Ordering Information

Ordering Number		Package	Pin Assignment								Packing
Lead Free	Halogen Free		1	2	3	4	5	6	7	8	
SM4818PRL	SM4818SRG	SOP-8	S2	G2	S1	G1	D1	D1	D2	D2	Tape Reel
<b>SM4818 X X X</b> 			(1) P: SOP-8 (2) R: Tape Reel (3) G: Halogen Free; L: Lead Free								



## ◆ Absolute Maximum Ratings ( $T_A=25^{\circ}\text{C}$ , unless otherwise noted)

Parameter	Symbol	Maximum	Units
Drain-Source Voltage	$V_{DS}$	30	V
Gate-Source Voltage	$V_{GS}$	$\pm 20$	V
Continuous Drain Current	$I_D$	$T_A=25^{\circ}\text{C}$	A
		$T_A=70^{\circ}\text{C}$	
Pulsed Drain Current <sup>c</sup>	$I_{DM}$	48	
Avalanche Current <sup>c</sup>	$I_{AS}, I_{AR}$	19	A
Avalanche energy $L=0.1\text{mH}$ <sup>c</sup>	$E_{AS}, E_{AR}$	18	mJ
Power Dissipation <sup>b</sup>	$P_D$	$T_A=25^{\circ}\text{C}$	W
		$T_A=70^{\circ}\text{C}$	
Junction and Storage Temperature Range	$T_J, T_{STG}$	-55 to 150	$^{\circ}\text{C}$

a: Fused current that based on wire numbers and diameter

b: Repetitive Rating: Pulse width limited by the maximum junction temperature

c: 1-in<sup>2</sup> 2oz Cu PCB board

## ◆ Electrical Characteristics ( $T_A=25^{\circ}\text{C}$ , unless otherwise noted)

Symbol	Parameter	Conditions	Min	Typ	Max	Units
<b>STATIC PARAMETERS</b>						
$BV_{DSS}$	Drain-Source Breakdown Voltage	$I_D=250\mu\text{A}, V_{GS}=0\text{V}$	30			V
$I_{DSS}$	Zero Gate Voltage Drain Current	$V_{DS}=30\text{V}, V_{GS}=0\text{V}$ $T_J=55^{\circ}\text{C}$			1	$\mu\text{A}$
					5	
$I_{GSS}$	Gate-Body leakage current	$V_{DS}=0\text{V}, V_{GS}=\pm 20\text{V}$			10	$\mu\text{A}$
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS}=V_{GS}, I_D=250\mu\text{A}$	1.2	1.8	2.4	V
$I_{D(ON)}$	On state drain current	$V_{GS}=10\text{V}, V_{DS}=5\text{V}$	30			A
$R_{DS(ON)}$	Static Drain-Source On-Resistance	$V_{GS}=10\text{V}, I_D=8\text{A}$ $T_J=125^{\circ}\text{C}$		15.5	19	m $\Omega$
				21	25	
		$V_{GS}=4.5\text{V}, I_D=4\text{A}$		18.5	23	m $\Omega$
$g_{FS}$	Forward Transconductance	$V_{DS}=5\text{V}, I_D=8\text{A}$		30		S
$V_{SD}$	Diode Forward Voltage	$I_S=1\text{A}, V_{GS}=0\text{V}$		0.75	1	V
$I_S$	Maximum Body-Diode Continuous Current				2.5	A
<b>DYNAMIC PARAMETERS</b>						
$C_{iss}$	Input Capacitance	$V_{GS}=0\text{V}, V_{DS}=15\text{V}, f=1\text{MHz}$	600	740	888	pF
$C_{oss}$	Output Capacitance		77	110	145	pF
$C_{rss}$	Reverse Transfer Capacitance		50	82	115	pF
$R_g$	Gate resistance	$V_{GS}=0\text{V}, V_{DS}=0\text{V}, f=1\text{MHz}$	0.5	1.1	1.7	$\Omega$
<b>SWITCHING PARAMETERS</b>						
$Q_g(10\text{V})$	Total Gate Charge	$V_{GS}=10\text{V}, V_{DS}=15\text{V}, I_D=8\text{A}$	12	15	18	nC
$Q_g(4.5\text{V})$	Total Gate Charge		6	7.5	9	nC
$Q_{gs}$	Gate Source Charge			2.5		nC
$Q_{gd}$	Gate Drain Charge			3		nC
$t_{D(on)}$	Turn-On Delay Time	$V_{GS}=10\text{V}, V_{DS}=15\text{V}, R_L=1.8\Omega,$ $R_{GEN}=3\Omega$		5		ns
$t_r$	Turn-On Rise Time			3.5		ns
$t_{D(off)}$	Turn-Off Delay Time			19		ns
$t_f$	Turn-Off Fall Time			3.5		ns
$t_{rr}$	Body Diode Reverse Recovery Time	$I_F=8\text{A}, dI/dt=500\text{A}/\mu\text{s}$	6	8	10	ns
$Q_{rr}$	Body Diode Reverse Recovery Charge	$I_F=8\text{A}, dI/dt=500\text{A}/\mu\text{s}$	14	18	22	nC

Note: Pulse Test: Pulse Width  $\leq 300\mu\text{s}$ , Duty Cycles  $\leq 2\%$

d: Guaranteed by design: not subject to production testing

## TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

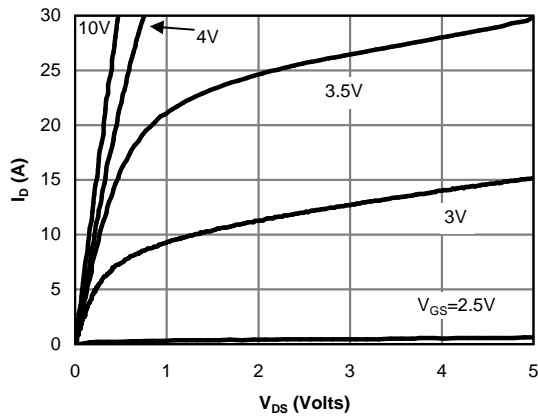


Figure 1: On-Region Characteristics (Note E)

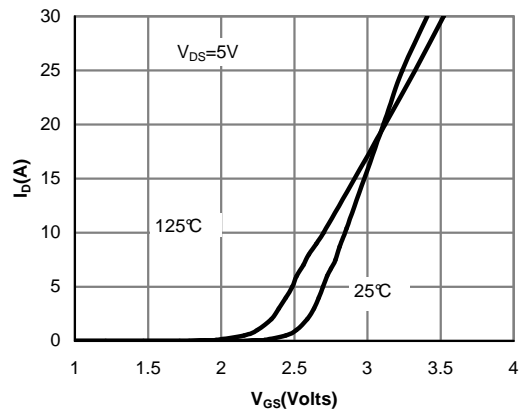


Figure 2: Transfer Characteristics (Note E)

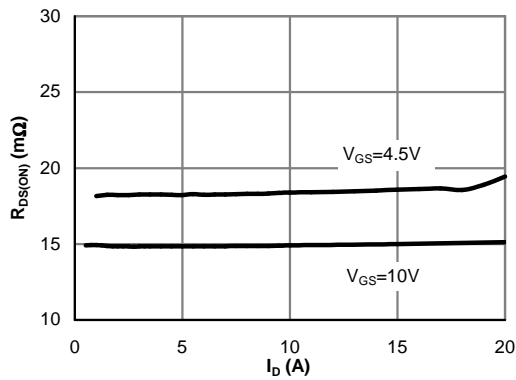


Figure 3: On-Resistance vs. Drain Current and Gate Voltage (Note E)

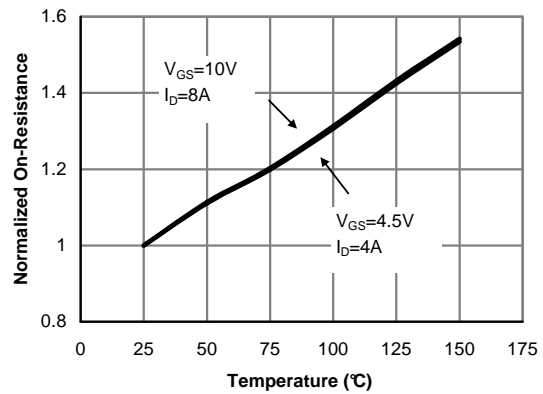


Figure 4: On-Resistance vs. Junction Temperature (Note E)

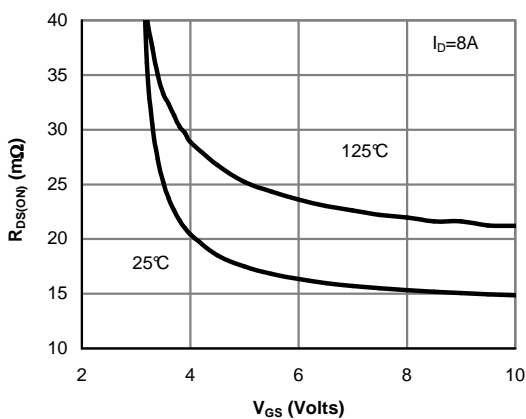


Figure 5: On-Resistance vs. Gate-Source Voltage (Note E)

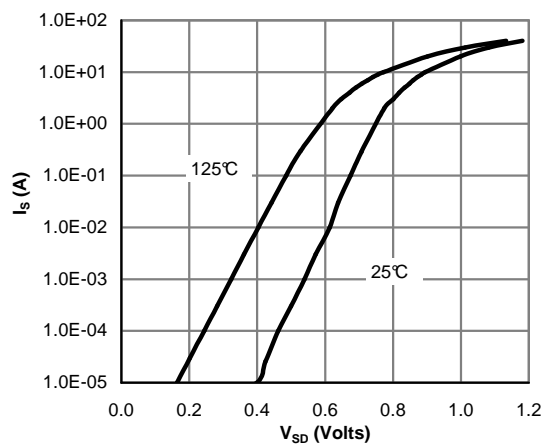


Figure 6: Body-Diode Characteristics (Note E)

## TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

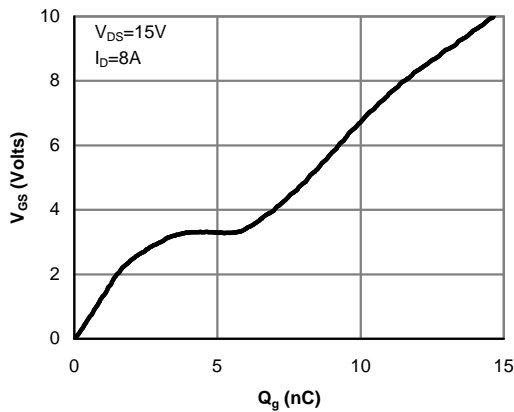


Figure 7: Gate-Charge Characteristics

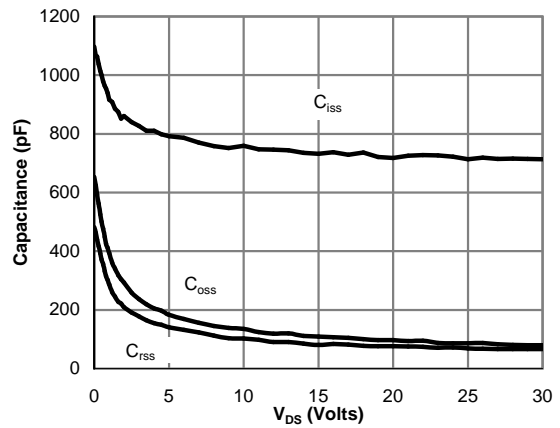


Figure 8: Capacitance Characteristics

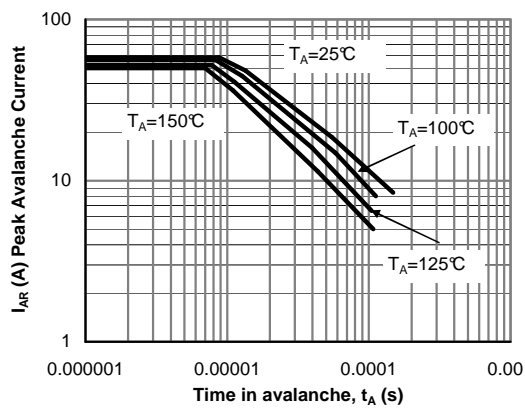


Figure 9: Single Pulse Avalanche capability (Note C)

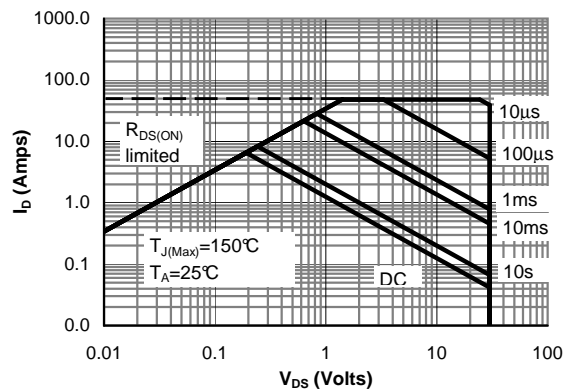


Figure 10: Maximum Forward Biased Safe Operating Area (Note F)

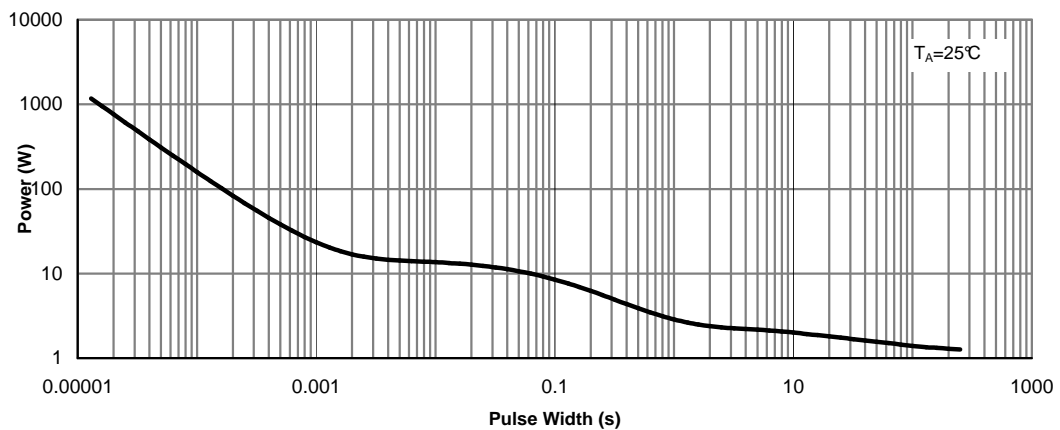
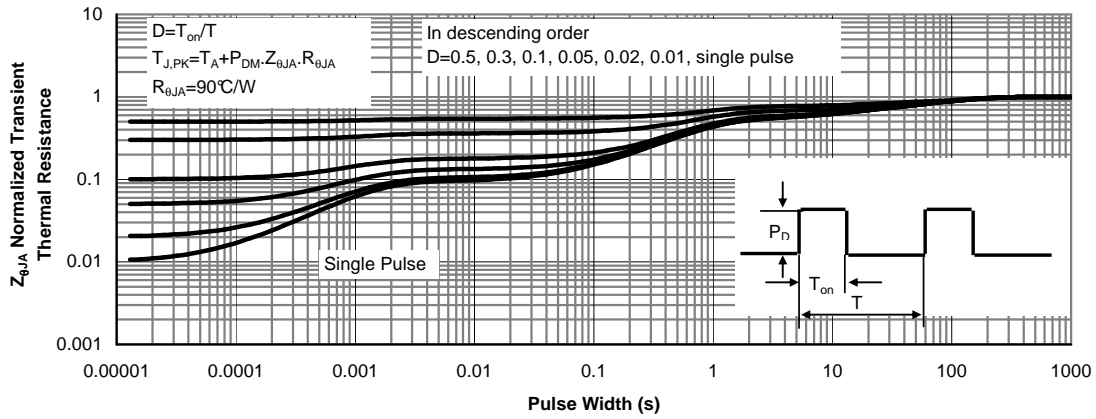
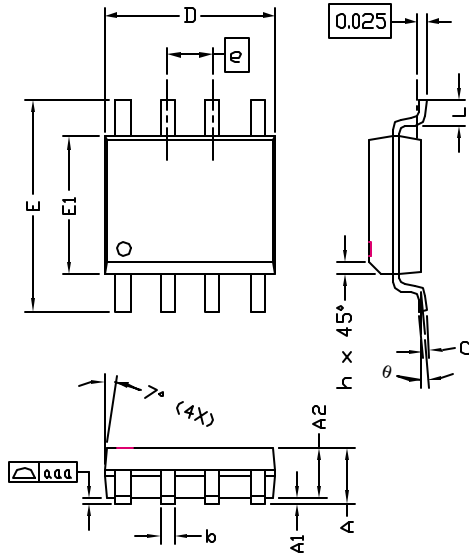


Figure 11: Single Pulse Power Rating Junction-to-Ambient (Note F)

## TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS



### SO-8 Package Data



SYMBOLS	DIMENSIONS IN MILLIMETERS			DIMENSIONS IN INCHES		
	MIN	NOM	MAX	MIN	NOM	MAX
A	1.45	1.50	1.55	0.057	0.059	0.061
A1	0.00	—	0.10	0.000	—	0.004
A2	—	1.45	—	—	0.057	—
b	0.33	—	0.51	0.013	—	0.020
c	0.19	—	0.25	0.007	—	0.010
D	4.80	—	5.00	0.189	—	0.197
E1	3.80	—	4.00	0.150	—	0.157
e	1.27 BSC			0.050 BSC		
E	5.80	—	6.20	0.228	—	0.244
h	0.25	—	0.50	0.010	—	0.020
L	0.40	—	1.27	0.016	—	0.050
aaa	—	—	0.10	—	—	0.004
$\theta$	0°	—	8°	0°	—	8°

NOTE:

1. LEAD FINISH: 150 MICROINCHES ( 3.8  $\mu$ m) MIN. THICKNESS OF Tin/Lead (SOLDER) PLATED ON LEAD
2. TOLERANCE  $\pm 0.100$  mm (4 mil) UNLESS OTHERWISE SPECIFIED
3. COPLANARITY : 0.1000 mm
4. DIMENSION L IS MEASURED IN GAGE PLANE